Application/Control No.	Applicant(s)/Patent Under Reexamination
10574466	KOOIJ, CHRISTIAAN JOHANNES
Examiner	Art Unit

Search Notes	10574466	KOOIJ, CHRIST
	Examiner	Art Unit
	YOSHITOSHI TAKEUCHI	4162

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
EAST text search (PG Pub, US Pat, EPO, JPO, Derwent		YT
Internet search		YT
Inventor search		YT

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

/YOSHITOSHI TAKEUCHI/ Examiner.Art Unit 4162	

U.S. Patent and Trademark Office Part of Paper No.: 20080904